TOSHIBA TC7SZ04F/FU

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC7SZ04F, TC7SZ04FU

#### INVERTER

#### **FEATURES**

High Output Drive : ± 24 mA (Typ.)

 $@V_{CC} = 3 V$ 

Super High Speed Operation : tpD 2.4 ns (Typ.)

 $@V_{CC} = 5 \text{ V}, 50 \text{ pF}$ 

Operation Voltage Range :  $V_{CC}$  (opr) = 1.8~5.5 V

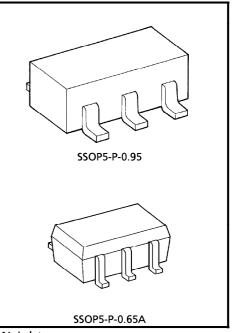
Supply Voltage Data Retention :  $V_{CC} = 1.5 \sim 5.5 \text{ V}$ 

**5 V Tolerant Function** 

Matches the Performance of TC74LCX Series when Operated at 3.3 V VCC

#### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	VCC	-0.5~6	V
DC Input Voltage	VIN	-0.5~6	V
DC Output Voltage	Vout	-0.5~6	V
Input Diode Current	Ιικ	± 20	mA
Output Diode Current	lok	± 20	mA
DC Output Current	lout	± 50	mA
DC V <sub>CC</sub> / Ground Current	lcc	± 50	mA
Power Dissipation	PD	200	mW
Storage Temperature	T <sub>stg</sub>	- 65~150	°C
Lead Temperature (10 s)	TL	260	°C



Weight SSOP5-P-0.95 : 0.016 g (Typ.) SSOP5-P-0.65A : 0.006 g (Typ.)

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# DC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC SYMBOL TEST CONDITION			.,	Ta = 25°C			Ta = -40~85°C			
CHARACTERISTIC	SAIMBOL	TEST CONDITION		Vсс (V)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
High-Level Input				1.8	0.88 × V <sub>C</sub> C	_	_	0.88 × V <sub>CC</sub>	_	.,
Voltage	V <sub>IH</sub>			2.3 – 5.5	0.75 × V <sub>CC</sub>	_	-	0.75 × V <sub>CC</sub>	_	V
Low-Level Input				1.8	_	_	0.12 × V <sub>CC</sub>		0.12 × V <sub>CC</sub>	>
Voltage	V <sub>IL</sub>			2.3 – 5.5	_		0.25 × V <sub>CC</sub>	_	0.25 × V <sub>CC</sub>	V
				1.8	1.7	1.8	_	1.7	_	V
			$I_{OH} = -100 \mu A$	2.3	2.2	2.3	_	2.2	_	
				3.0	2.9	3.0	_	2.9	_	
High-Level	VOH	$V_{IN} = V_{IL}$		4.5	4.4	4.5		4.4	_	
Output Voltage	- ОП	THIN - VIL	$I_{OH} = -8  \text{mA}$	2.3	1.9	2.15	_	1.9	_	
			$I_{OH} = -16  \text{mA}$	3.0	2.4	2.8		2.4	_	
			$I_{OH} = -24  \text{mA}$	3.0	2.3	2.68		2.3	_	
			$I_{OH} = -32 \text{ mA}$	4.5	3.8	4.2		3.8		
			I <sub>OL</sub> = 100 μA	1.8		0	0.1	_	0.1	- V
				2.3		0	0.1	_	0.1	
				3.0		0	0.1	_	0.1	
Low-Level	VOL	V <sub>IN</sub> = V <sub>IH</sub>		4.5		0	0.1		0.1	
Output Voltage			I <sub>OL</sub> = 8 mA	2.3		0.1	0.3		0.3	
			I <sub>OL</sub> = 16 mA	3.0		0.15	0.4	_	0.4	
			I <sub>OL</sub> = 24 mA	3.0		0.22	0.55	_	0.55	
lan ( lanka			I <sub>OL</sub> = 32 mA	4.5		0.22	0.55	_	0.55	
Input Leakage Current	lIN	V <sub>IN</sub> = 5.5 \	or GND	0 – 5.5	_	_	± 1	_	± 10	μΑ
Power Off Leakage Current	lOFF	V <sub>IN</sub> or V <sub>OUT</sub> = 5.5 V		0.0	_	_	1	_	10	μΑ
Quiescent Supply Current	ICC	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	_	_	2	_	20	μΑ

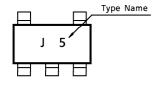
AC ELECTRICAL	<b>CHARACTERISTICS</b>	(Input $t_r = $	$t_f = 3 \text{ ns}$
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CHARACTERISTIC SYMBOL		TEST CONDITION		Ta = 25°C			Ta = -4	LINUT	
CHARACTERISTIC	SYMBOL	TEST CONDITION	V <sub>CC</sub> (V)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
Propagation tPLH			1.8	2.0	4.4	9.5	2.0	10.0	
		CL = 15 pF,	2.5 ± 0.2	0.8	2.9	6.5	0.8	7.0	
	$RL = 1 M\Omega$	3.3 ± 0.3	0.5	2.1	4.5	0.5	4.7		
Delay Time	y Time tPHL		5.0 ± 0.5	0.5	1.8	3.9	0.5	4.1	ns
		CL = 50 pF,	3.3 ± 0.3	1.5	2.9	5.0	1.5	5.2	
		$RL = 500 \Omega$	5.0 ± 0.5	0.8	2.4	4.3	0.8	4.5	
Input Capacitance	CIN		0 - 5.5	_	4	_	_	_	рF
Power Dissipation	C	er Dissipation (Note 1)	3.3	_	20	_	_	_	nE
Capacitance	C <sub>PD</sub>	(Note 1)	5.5	_	26	_	_	_	pF

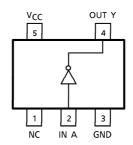
(Note 1) CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

$$ICC (opr) = CPD \cdot VCC \cdot fIN + ICC$$

## **MARKING**



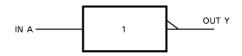
# PIN ASSIGNMENT (TOP VIEW)



# TRUTH TABLE

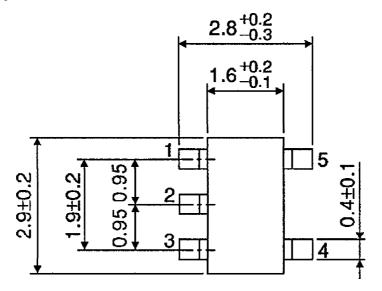
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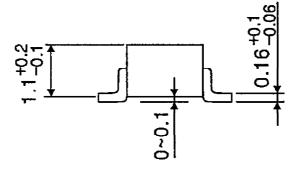
**LOGIC DIAGRAM** 



## OUTLINE DRAWING SSOP5-P-0.95

Unit: mm

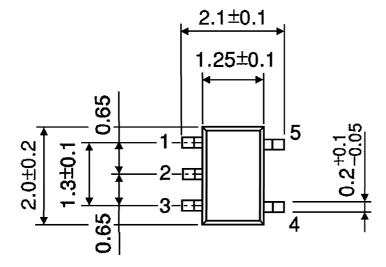


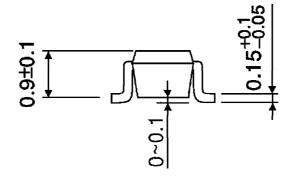


Weight: 0.016 g (Typ.)

## OUTLINE DRAWING SSOP5-P-0.65A

Unit: mm





Weight: 0.006 g (Typ.)